

2450

SourceMeter® SMU Instrument



The Model 2450 is Keithley's next-generation SourceMeter source measure unit (SMU) Instrument that truly brings Ohm's law (current, voltage, and resistance) testing right to your fingertips. Its innovative graphical user interface (GUI) and advanced, capacitive touchscreen technology allow intuitive usage and minimize the learning curve to enable engineers and scientists to learn faster, work smarter, and invent easier. The 2450 is the SMU for everyone: a versatile instrument, particularly well-suited for characterizing modern scaled semiconductors, nano-scale devices and materials, organic semiconductors, printed electronics, and other small-geometry and low-power devices. All this combined with Keithley SMU precision and accuracy allow users to Touch, Test, Invent™ with the new favorite go-to instrument in the lab for years to come.

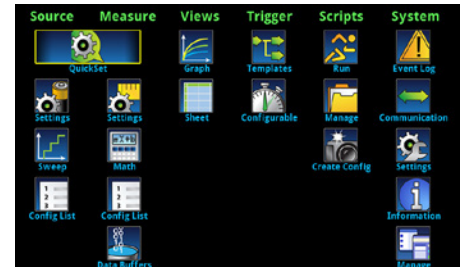
- Capabilities of analyzers, curve tracers, and I-V systems at a fraction of their cost.
- Five-inch, high resolution capacitive touchscreen GUI
- 0.012% basic measure accuracy with 6½-digit resolution
- Enhanced sensitivity with new 20mV and 10nA source/measure ranges
- Source and sink (4-quadrant) operation
- Four "Quickset" modes for fast setup and measurements
- Built-in, context-sensitive front panel help
- Front panel input banana jacks; rear panel input triaxial connections
- 2450 enhanced SCPI and TSP® scripting programming modes
- Model 2400 SCPI-compatible programming mode
- Front panel USB memory port for data/programming/configuration I/O

Learn Faster, Work Smarter, Invent Easier

Unlike conventional instruments with dedicated pushbutton technology and small, obscure, limited-character displays, the 2450 features a five-inch, full-color, high resolution touchscreen that facilitates ease of use and learning and optimizes overall speed and productivity. A simple menu structure reduces configuration steps by as much as 50 percent and eliminates the cumbersome multi-layer menu structures typically used on soft-key instruments. Built-in, context-sensitive help enables intuitive operation and minimizes the need to review a separate manual. These capabilities combined with its application versatility make the 2450 the SMU instrument inherently easy to use for basic and advanced measurement applications, regardless of your experience level with SMU instruments.



2450 main home screen.

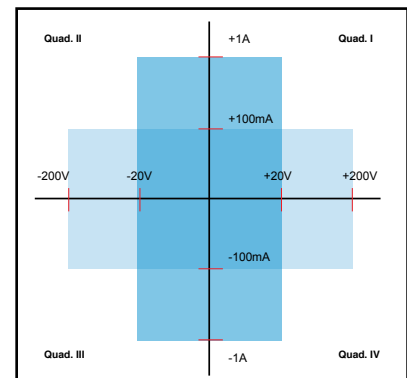


View of 2450 menu.

Fourth-Generation, All-in-One SMU Instrument

The 2450 is the fourth-generation member of Keithley's award-winning SourceMeter family of SMU instruments and is based on the proven architecture of the Model 2400 SourceMeter SMU Instrument. It offers a highly flexible, four-quadrant voltage and current source/load coupled with precision voltage and current meters. This all-in-one instrument can be used as a:

- Precision power supply with V and I readback
- True current source
- Digital multimeter (DCV, DCI, ohms, and power with 6½-digit resolution).
- Precision electronic load
- Trigger controller



2450 power envelope.

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SourceMeter® SMU Instrument

Ordering Information

2450	200V, 1A, 20W SourceMeter Instrument
2450-NFP	200V, 1A, 20W SourceMeter Instrument, with No Front Panel
2450-RACK	200V, 1A, 20W SourceMeter Instrument, without Handle
2450-NFP-RACK	200V, 1A, 20W SourceMeter Instrument, with No Front Panel and No Handle

Accessories Supplied

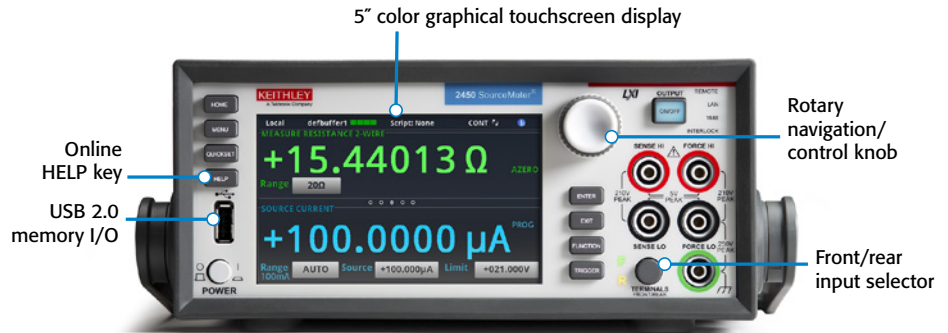
8608	High Performance Test Leads
USB-B-1	USB Cable, Type A to Type B, 1m (3.3 ft)
CS-1616-3	Safety Interlock Mating Connector
CA-180-3A	TSP-Link/Ethernet Cable
	Documentation CD
	2450 QuickStart Guide
	Test Script Builder Software (supplied on CD)
	KickStart Startup Software (supplied on CD)
	LabVIEW and IVI Drivers (supplied on CD)

Model 2400	Model 2450
V-Ranges: 200mV – 200V	V-Ranges: 20mV – 200V
I-Ranges: 1 μ A – 1A	I-Ranges: 10nA – 1A
0.012% Basic Accuracy	0.012% Basic Accuracy
Wideband Noise: 4mV _{rms} Typ.	Wideband Noise: 2mV _{rms} Typ.
Sweep Types: Linear, Log, Custom, Source-Memory	Sweep Types: Linear, Log, Dual Linear, Dual Log, Custom, Source-Memory (2400 SCPI Mode)
5000 Reading Buffer	>250,000 Reading Buffer
SCPI Programming	2400 + 2450 SCPI + TSP Programming
GPIO	GPIO, USB, Ethernet (LXI)
Front/Rear Banana Jacks	Front: Banana Jacks, Rear: Triax

Comparison of Model 2400 vs Model 2450.

Ease of Use Beyond the Touchscreen

In addition to its five-inch, color touchscreen, the 2450 front panel has many features that supplement its speed, user-friendliness, and learnability, including a USB 2.0 memory I/O port, a HELP key, a rotary navigation/control knob, a front/rear input selector button, and banana jacks for basic bench applications. The USB 2.0 memory port supports easy data storing, saving instrument configurations, loading test scripts, and system upgrades. Plus, all front panel buttons are backlit to enhance visibility in low-light environments.

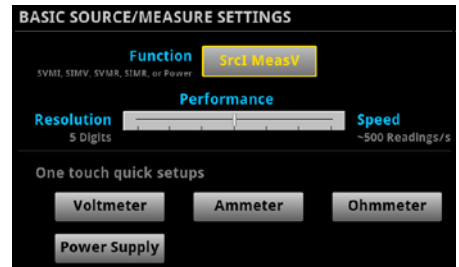


Model 2450 front panel with high resolution, capacitive touchscreen.

Four “Quickset” modes simplify user setup. With one touch, the instrument can be quickly configured for various operating modes without the need to configure the instrument indirectly for this operation.

Comprehensive Built-in Connectivity

Rear panel access to rear-input triax connectors, remote control interfaces (GPIO, USB 2.0, and LXI/Ethernet), D-sub 9-pin digital I/O port (for internal/external trigger signals and handler control), instrument interlock control, and TSP-Link® jacks enables easy configuration of multiple instrument test solutions and eliminates the need to invest in additional adapter accessories.



Quickset modes enable fast setup and time to measurements.

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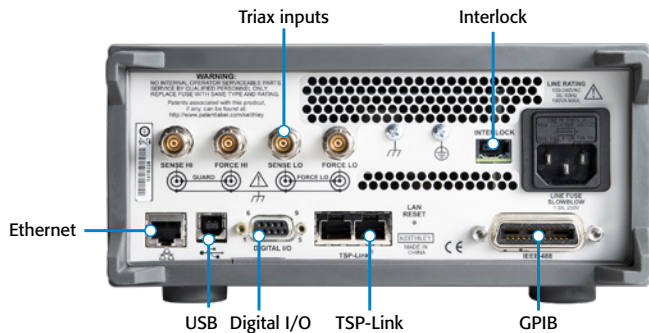
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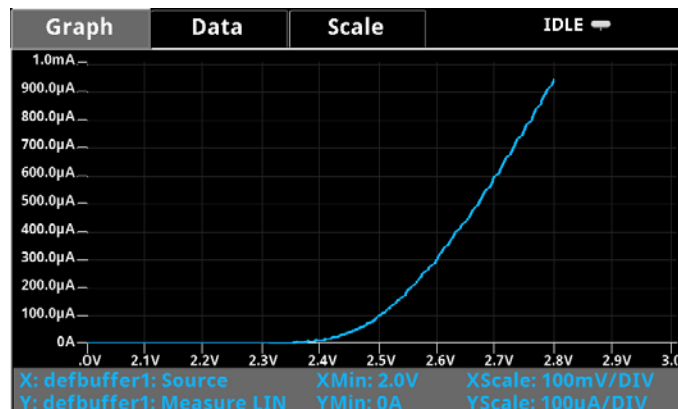
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Rear panel connections are optimized for signal integrity.

Convert Raw Data to Information

The 2450 provides a full plotting and sheet view to display sweeps, measurement data, and charting right on the screen. It also supports exporting to a spreadsheet for further analysis, dramatically improving productivity for research, bench-top testing, device qualification, and debugging.



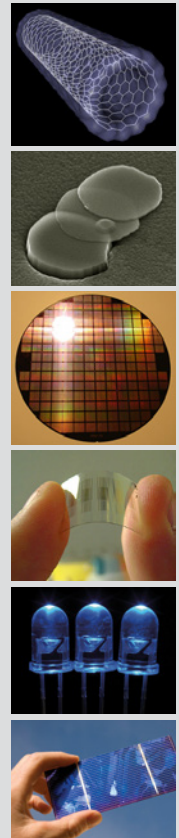
DATA SHEET			
Buffer	defbuffer1	Jump	Refresh
	Time	Source	Measure
1	05/08 09:50	0	-2.51326e-07
2	09:50:03.6	0.1	6.38803e-05
3	09:50:05.3	0.2	0.000127991
4	09:50:05.8	0.3	0.00019225
5	09:50:06.4	0.4	0.000256259
6	09:50:06.9	0.5	0.000320488
7	09:50:07.5	0.6	0.000384533
8	09:50:08.0	0.7	0.000448547
9	09:50:08.6	0.8	0.000512793
10	09:50:09.1	0.9	0.000576823
11	09:50:09.7	1	0.000641066

Full data display, charting, and export to a spreadsheet lets you convert raw data to useful information.

TYPICAL APPLICATIONS

Ideal for current/voltage characterization and functional test of a wide range of today's modern electronics and devices, including:

- **Nanomaterials and Devices**
 - Graphene
 - Carbon nanotubes
 - Nanowires
 - Low power nanostructures
- **Semiconductor Structures**
 - Wafers
 - Thin films
- **Organic Materials and Devices**
 - E-inks
 - Printable electronics
- **Energy Efficiency and Lighting**
 - LEDs/AMOLEDs
 - Photovoltaics/Solar Cells
 - Batteries
- **Discrete and Passive Components**
 - Two-leaded: Resistors, diodes, zener diodes, LEDs, disk drive heads, sensors
 - Three-leaded: Small signal bipolar junction transistors (BJTs), field effect transistors (FETs), and more
- **Material Characterization**
 - Resistivity
 - Hall Effect



TriggerFlow™ Building Blocks for Instrument Control and Execution

The 2450 incorporates Keithley's new TriggerFlow triggering system that allows user control of instrument execution. Similar to developing a flow chart, TriggerFlow diagrams are created using four fundamental building blocks:

- **Wait** – Waits for an event to occur before the flow continues
- **Branch** – Branches when a condition has been satisfied
- **Action** – Initiates an action in the instrument, for example, measure, source, delay, set digital I/O, etc.
- **Notify** – Notifies other equipment that an event has occurred

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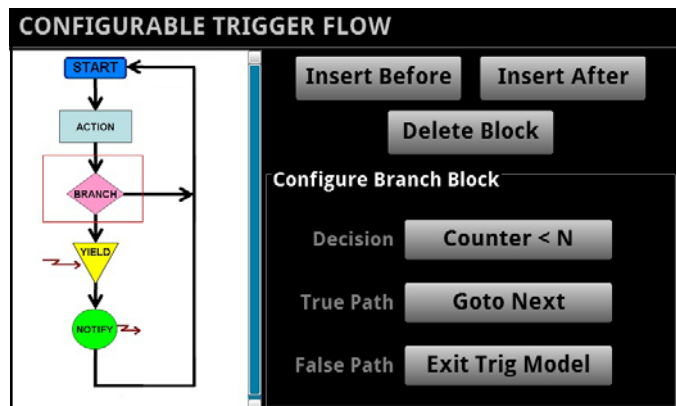
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Model 2450 SourceMeter® SMU Instrument

SMU INSTRUMENTS

2450

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TriggerFlow building blocks let users create very simple to very complex triggering models.

A TriggerFlow model using a combination of these building blocks can be created from the front panel or by sending remote commands. With the TriggerFlow system, users can build triggering models from very simple to complex with up to 255 block levels. The 2450 also includes basic triggering functions, including immediate, timer, and manual triggering.

Unmatched System Integration and Programming Flexibility

When the 2450 is integrated as part of a multi-channel I-V test system, the Test Script Processor (TSP®) embedded scripting capability allows test scripts to be run by the instrument, enabling the user to create powerful measurement applications with significantly reduced development times. TSP technology also offers channel expansion without a mainframe. Keithley's TSP-Link® channel expansion bus, which uses a 100 Base T Ethernet cable, connects multiple 2450 instruments and other TSP instruments such as Keithley's Series 2600B SourceMeter SMU instruments and Series 3700A Switch/Multimeter systems in a master-slave configuration that behaves as one integrated system. The TSP-Link expansion bus supports up to 32 units per GPIB or IP address, making it easy to scale a system to fit an application's particular requirements.

The 2450 also includes a standard SCPI programming mode that optimizes the instrument's new features, as well as a 2400 SCPI mode that provides backwards compatibility with existing 2400 SourceMeter instruments. Not only does this preserve your 2400 investment, but it also eliminates re-work normally associated with upgrading to a new instrument with new capabilities.

Parallel Test Capability

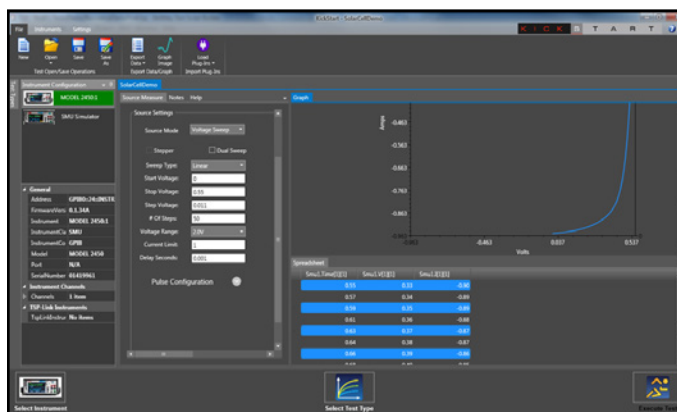
With the TSP technology in the 2450, multiple devices can be tested in parallel to meet the needs of device research, advanced semiconductor lab applications, and even high throughput production test. This parallel testing capability enables each instrument in the system to run its own complete test sequence, creating a fully multi-threaded test environment. The number of tests that can be run in parallel on a 2450 can be as high as the number of instruments in the system.

Free Instrument Control Start-up Software and Web Interface

KickStart, Keithley's new instrument control non-programming start-up software, lets users start taking measurements in minutes. In most cases, users merely need to make quick measurements, graph the data, and store the data to disk to perform analysis in software environments such as Excel.

KickStart offers the following functionality:

- Instrument configuration control to perform I-V characterization
- Native X-Y graphing, panning, and zooming
- Spreadsheet/tabular viewing of data
- Saving and exporting data for further analysis
- Saving of test setups
- Screenshot capturing of graph
- Annotation of tests
- Command line dialog for sending and receiving data
- HTML help
- GPIB, USB 2.0, Ethernet compliant



With KickStart start-up software, users are ready to take measurements in minutes.

Simplified Programming with Ready-to-Use Instrument Drivers

For users who want to create their own customized application software, native National Instruments LabVIEW® drivers, IVI-C, and IVI-COM drivers are available at www.keithley.com.

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ACCESSORIES AVAILABLE

TEST LEADS AND PROBES

1754	2-wire Universal 10-Piece Test Lead Kit
5804	Kelvin (4-Wire) Universal 10-Piece Test Lead Kit
5805	Kelvin (4-Wire) Spring-Loaded Probes
5806	Kelvin Clip Lead Set
5808	Low Cost Single-pin Kelvin Probe Set
5809	Low Cost Kelvin Clip Lead Set
8605	High Performance Modular Test Leads
8606	High Performance Modular Probe Kit
8608	High Performance Clip Lead Set

CABLES, CONNECTORS, ADAPTERS

237-ALG-2	3-slot Male Triax Connector to 3 Alligator Clips
237-BAN-3A	Triax to Banana Plug
2450-TRX-BAN	Triax to Banana Adapter. Converts the 4 Triax adapters on the rear panel to 5 banana jacks
7078-TRX.*	3-slot, Low Noise Triax Cable
7078-TRX-GND	3-slot Male Triax To BNC Adapter (guard removed)
8607	2-wire, 1000V Banana Cables, 1m (3.3 ft)
CA-18-1	Shielded Dual Banana Cable, 1.2m (4 ft)
CAP-31	Protective Shield/Cap for 3-lug Triax Connectors
CS-1546	Triax 3-lug Special Shorting Plug. Shorts center pin to outer shield
CS-1616-3	Safety Interlock Mating Connector

COMMUNICATION INTERFACES & CABLES

KPCI-488LPA	IEEE-488 Interface for PCI Bus
KUSB-488B	IEEE-488 USB-to-GPIB Interface Adapter
7007-1	Shielded GPIB Cable, 1m (3.3 ft)
7007-2	Shielded GPIB Cable, 1m (6.6 ft)
CA-180-3A	CAT5 Crossover Cable for TSP-Link/Ethernet
USB-B-1	USB Cable, Type A to Type B, 1m (3.3 ft)

TRIGGERING AND CONTROL

2450-TLINK	DB-9 to Trigger Link Connector Adapter.
8501-1	Trigger Link Cable, DIN-to-DIN, 1m (3.3 ft)
8501-2	Trigger Link Cable, DIN-to-DIN, 2m (6.6 ft)

RACK MOUNT KITS

4299-8	Single Fixed Rack Mount Kit
4299-9	Dual Fixed Rack Mount Kit
4299-10	Dual Fixed Rack Mount Kit. Mount one 2450 and one Series 26xxB
4299-11	Dual Fixed Rack Mount Kit. Mount one 2450 and one Series 2400, Series 2000, etc.
2450-BenchKit	Ears and Handle for 2450-NFP-RACK and 2450-RACK models

TEST FIXTURES

8101-PIV	DC Test Fixture
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SERVICES AVAILABLE

2450-3Y-EW	1 Year Factory Warranty extended to 3 years from date of shipment
2450-5Y-EW	1 Year Factory Warranty extended to 5 years from date of shipment
C/2450-3Y-17025	KeithleyCare® 3 Year ISO 17025 Calibration Plan
C/2450-3Y-DATA	KeithleyCare 3 Year Calibration w/Data Plan
C/2450-3Y-STD	KeithleyCare 3 Year Std. Calibration Plan
C/2450-5Y-17025	KeithleyCare 5 Year ISO 17025 Calibration Plan
C/2450-5Y-DATA	KeithleyCare 5 Year Calibration w/Data Plan
C/2450-5Y-STD	KeithleyCare 5 Year Std. Calibration Plan

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Voltage Specifications^{1,7}

Source				Measure ²		
Range	Resolution	Accuracy (23° ± 5°C)	Noise (RMS)	Resolution	Input Resistance	Accuracy (23° ± 5°C)
		1 Year ±(% setting + volts)	(<10Hz)			1 Year ±(% rdg. + volts)
20.00000 mV	500 nV	0.100% + 200 μ V	1 μ V	10 nV	>10 G Ω	0.100% + 150 μ V
200.0000 mV	5 μ V	0.015% + 200 μ V	1 μ V	100 nV	>10 G Ω	0.012% + 200 μ V
2.000000 V	50 μ V	0.020% + 300 μ V	10 μ V	1 μ V	>10 G Ω	0.012% + 300 μ V
20.00000 V	500 μ V	0.015% + 2.4 mV	100 μ V	10 μ V	>10 G Ω	0.015% + 1 mV
200.0000 V	5 mV	0.015% + 24 mV	1 mV	100 μ V	>10 G Ω	0.015% + 10 mV

Current Specifications^{1,7}

Source				Measure ²		
Range	Resolution	Accuracy (23° ± 5°C) ³	Noise (RMS)	Resolution	Voltage Burden	Accuracy (23° ± 5°C)
		±(% setting + amps)	(<10Hz)			1 Year ±(% rdg. + amps)
10.00000 nA ⁴	500 fA	0.100% + 100 pA	500 fA	10 fA	<100 μ V	0.10% + 50 pA
100.0000 nA ⁴	5 pA	0.060% + 150 pA	500 fA	100 fA	<100 μ V	0.060% + 100 pA
1.000000 μ A	50 pA	0.025% + 400 pA	5 pA	1 pA	<100 μ V	0.025% + 300 pA
10.00000 μ A	500 pA	0.025% + 1.5 nA	40 pA	10 pA	<100 μ V	0.025% + 700 pA
100.0000 μ A	5 nA	0.020% + 15 nA	400 pA	100 pA	<100 μ V	0.02% + 6 nA
1.000000 mA	50 nA	0.020% + 150 nA	5 nA	1 nA	<100 μ V	0.02% + 60 nA
10.00000 mA	500 nA	0.020% + 1.5 μ A	40 nA	10 nA	<100 μ V	0.02% + 600 nA
100.0000 mA	5 μ A	0.025% + 15 μ A	100 nA	100 nA	<100 μ V	0.025% + 6 μ A
1.000000 A	50 μ A	0.067% + 900 μ A	3 μ A	1 μ A	<100 μ V	0.03% + 500 μ A

TEMPERATURE COEFFICIENT (0°–18°C and 28°–50°C): $\pm(0.15 \times \text{accuracy specification})/^{\circ}\text{C}$.

1. Speed = 1 PLC.

2. Accuracies apply to 2- and 4-wire mode when properly zeroed.

3. For sink mode, 1 μ A to 100mA range accuracy is $\pm(0.15\% + \text{offset}^*4)$. For 1A range, accuracy is $\pm(1.5\% + \text{offset}^*8)$.

4. Rear panel triax connections only.

Resistance Measurement Accuracy (Local or Remote Sense)⁷

Range	Default Resolution	Default Test Current	Normal Accuracy (23°C ± 5°C)		Enhanced Accuracy ⁶ (23°C ± 5°C)	
			1 Year, $\pm(\% \text{ rdg.} + \text{ohms})$		1 Year, $\pm(\% \text{ rdg.} + \text{ohms})$	
<2.000000 Ω^5	1 $\mu\Omega$	—	Source $I_{\text{ACC}} + \text{Meas. } V_{\text{ACC}}$		Meas. $I_{\text{ACC}} + \text{Meas. } V_{\text{ACC}}$	
20.00000 Ω	10 $\mu\Omega$	100 mA	0.098% + 0.003 Ω		0.073% + 0.001 Ω	
200.0000 Ω	100 $\mu\Omega$	10 mA	0.077% + 0.03 Ω		0.053% + 0.01 Ω	
2.000000 k Ω	1 m Ω	1 mA	0.066% + 0.3 Ω		0.045% + 0.1 Ω	
20.00000 k Ω	10 m Ω	100 μ A	0.063% + 3 Ω		0.043% + 1 Ω	
200.0000 k Ω	100 m Ω	10 μ A	0.065% + 30 Ω		0.046% + 10 Ω	
2.000000 M Ω	1 Ω	1 μ A	0.11% + 300 Ω		0.049% + 100 Ω	
20.00000 M Ω	10 Ω	1 μ A	0.11% + 1000 Ω		0.052% + 500 Ω	
200.0000 M Ω	100 Ω	100 nA	0.655% + 10 k Ω		0.349% + 5000 Ω	
>200.0000 M Ω^5	—	—	Source $I_{\text{ACC}} + \text{Meas. } V_{\text{ACC}}$		Meas. $I_{\text{ACC}} + \text{Meas. } V_{\text{ACC}}$	

TEMPERATURE COEFFICIENT (0°–18°C and 28°–50°C): $\pm(0.15 \times \text{accuracy specification})/^{\circ}\text{C}$.

SOURCE I MODE, MANUAL OHMS: Total uncertainty = I source accuracy + V measure accuracy (4-wire remote sense).

SOURCE V MODE, MANUAL OHMS: Total uncertainty = V source accuracy + I measure accuracy (4-wire remote sense).

GUARD OUTPUT IMPEDANCE: 0.5 Ω (dc) in ohms mode.

5. Manual ohms only.

6. Source readback enabled. Offset compensation ON.

7. All specifications are guaranteed with output ON.

OPERATING CHARACTERISTICS

MAX. OUTPUT POWER: 20W, four-quadrant source or sink operation.

SOURCE/SINK LIMITS: **Vsource:** $\pm 20\text{V}$ @ $\pm 1.00\text{A}$, $\pm 200\text{V}$ @ $\pm 100\text{mA}$.

Isource: $\pm 1.00\text{A}$ @ $\pm 20\text{V}$, $\pm 100\text{mA}$ @ $\pm 200\text{V}$.

REGULATION: **Voltage:** **Line:** 0.01% of range. **Load:** 0.01% of range + 100 μV .

Current: **Line:** 0.01% of range. **Load:** 0.01% of range + 100pA.

SOURCE LIMITS: **Voltage Source Current Limit:** Bipolar current limit set with single value. Min. 10% of range.

Current Source Voltage Limit: Bipolar voltage limit set with single value. Min. 10% of range.

OVERSHOOT: **Voltage Source:** <0.1% typical (full scale step, resistive load, 20V range, 10mA I-Limit).

Current Source: <0.1% typical (1mA step, $R_{\text{load}} = 10\text{k}\Omega$, 20V range)

VOLTAGE SOURCE: **Noise 10Hz–1MHz (RMS):** 2mV typical into a resistive load.

OVER VOLTAGE PROTECTION: User selectable values, 5% tolerance. Factory default = none.

OUTPUT SETTLING TIME: Time required to reach 0.1% of final value, 20V range, 100mA I-Limit: <200 μs typical.

MAXIMUM SLEW RATE: 0.2V/ μs .

V/I-LIMIT ACCURACY: Add 0.3% of setting and $\pm 0.02\%$ of reading to base specification.

RANGE CHANGE OVERSHOOT: Overshoot into a fully resistive 100k Ω load, 10Hz to 1MHz BW, adjacent ranges: 100mV typical.

System Measurement Speeds**READING RATES (READINGS/SECOND) TYPICAL**

SCRIPT (TSP) Programmed

NPLC/Trigger Origin	Measure				Source-Measure Sweep			
	To Mem.	To GPIB	To USB	To LAN	To Mem.	To GPIB	To USB	To LAN
0.01 / Internal	1355	1296	1295	1295	1129	1088	1085	1088
0.1 / Internal	546	532	532	532	501	492	491	492
1.00 / Internal	59	59	59	59	58	58	58	58

GENERAL CHARACTERISTICS (default mode unless specified)**FACTORY DEFAULT STANDARD POWER-UP: 2450 SCPI MODE.****NOISE REJECTION (TYPICAL):**

NPLC	NMRR	CMRR
0.01	—	60 dB
0.1	—	60 dB
1	60 dB	100 dB ¹

1. Except lowest two current ranges ~90dB.

LOAD IMPEDANCE: Stable into 50 μ F typical (High-C mode).

20nF typical (standard). High-C mode not valid for 20mV range.

High-C mode not valid in 2400 SCPI mode.

COMMON MODE VOLTAGE: 250V DC.**COMMON MODE ISOLATION:** >1G Ω , <1000pF.**OVERRRANGE:** 105% of range, source and measure.**MAX. VOLTAGE DROP BETWEEN FORCE AND SENSE TERMINALS:** 5V.**MAX. SENSE LEAD RESISTANCE:** 1M Ω for rated accuracy.**SENSE INPUT IMPEDANCE:** >10G Ω .**GUARD OFFSET VOLTAGE:** <300 μ V, typical**SOURCE OUTPUT MODES:** Fixed DC Level, Memory/Configuration

List (mixed function), Stair (linear and log).

SOURCE MEMORY LIST: 100 points max. (2400 SCPI Mode only).**MEMORY BUFFER:** >250,000 readings. Includes selected measured value(s)

and time stamp. NVRAM: Lithium battery backup (3 yr.+ battery life).

REMOTE INTERFACES:**GPIB:** (IEEE-488.2)**USB Device (rear panel, type B):** 2.0 Full Speed USBTMC**USB Device (front panel, type A):** USB 2.0, support for thumb drives**Ethernet:** RJ-45 (10/100BT)**IP CONFIGURATION:** Static or DHCP**EXPANSION INTERFACE:** The TSP-Link expansion interface allows

TSP enabled instruments to trigger and communicate with each other.

LXI COMPLIANCE: 1.4 LXI Core 2011.**PROGRAMMABILITY:****SCPI Mode:** IEEE-488.1 compliant. Supports IEEE-488.2 common commands and status model topology. SCPI-1996.0 Compliant.**TSP Mode:** Embedded Test Script Processor (TSP) accessible from any host interface.**INPUT SIGNAL CONNECTIONS:** **Front:** Banana. **Rear:** Triaxial (3-Lug)**DIGITAL I/O INTERFACE:****Lines:** 6 Input/Output user defined for digital I/O or triggering**Connector:** 9-pin female D**Input Signal Levels:** 0.7 V (maximum logic low), 3.7 V (minimum logic high)**Input Voltage Limits:** -0.25 V (Abs. minimum), +5.25 V (Abs. maximum)**Maximum Source Current:** +2.0 mA @ >2.7 V (per pin)**Maximum Sink Current:** -50 mA @ 0.7 V (per pin, solid-state fuse protected)**5 V Power Supply Pin:** Limited to 500 mA @ >4V (solid-state fuse protected)**Handler:** User definable Start of Test, End of Test, 4 category bits**COOLING:** Forced air, variable speed.**OVER TEMPERATURE PROTECTION:** Internally sensed temperature overload puts unit in standby mode.**POWER SUPPLY:** 100V to 240V RMS, 50–60Hz (automatically detected at power up).**VA RATING:** 190 volt-amps max.**ALTITUDE:** Maximum 2000 meters above sea level.**EMC:** Conforms to European Union EMC Directive.**SAFETY:** NRTL listed to UL61010-1 and UL61010-2-30. Conforms with European Union Low Voltage Directive.**VIBRATION:** MIL-PRF-28800F Class 3 Random.**WARM-UP:** 1 hour to rated accuracies.**DIMENSIONS:** (With handle and bumpers): 106mm high \times 255mm wide \times 425mm deep (4.18 in \times 10.05 in \times 16.75 in). (Without handle and bumpers): 88mm high \times 213mm wide \times 403mm deep (3.47 in \times 8.42 in \times 15.9 in).**WEIGHT:** With bumpers & handle: 4.04 kg (8.9 lbs.). Without bumpers & handle 3.58 kg (7.9 lbs.).**ENVIRONMENT: Operating:** 0°–50°C, 70% R.H. up to 35°C. Derate 3% R.H./°C, 35°–50°C.**Storage:** –25°C to 65°C.**ACCESSORIES SUPPLIED:** Test Leads, USB Cable, Interlock Adapter, CD User's Manual.

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SourceMeter® SMU Instrument

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